

<b>Notice of References Cited</b>	Application/Control No. <b>09/773,172</b>	Applicant(s)/Patent Under Reexam <b>Mark Edward Epstein</b>	
	Examiner <b>Talivaldis Ivars Smits</b>	Art Unit <b>2654</b>	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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<sup>1</sup> Dates in MM-YYYY format are publication dates.

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